

Search Notes

Application/Control No.

10/526,150

Examiner

Chau N. Nguyen

Applicant(s)/Patent under
Reexamination

WEYL ET AL.

Art Unit

2831

SEARCHED

| Class | Subclass | Date | Examiner |
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| 174 | 28 | 6/7/2007 | CN |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

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